

CERTIFICATE OF MAILING

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Date: September 30, 2004

M Mehta

Monica Mehta

PATENT
905900-290



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: GEORGE BORSHUKOV

Serial No.: 10/715,870

Art Unit: 2125

Filed: November 17, 2003

Examiner:

Title: METHOD FOR DIGITALLY
RENDERING AN OBJECT USING
MEASURED BRDF DATA

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In accordance with 37 C.F.R. § 1.56, Applicants submit herewith the attached Information Disclosure Statement Form PTO-1449 in connection with the above-identified patent application along with a copy of the five (5) non-U.S. patent references listed in the Form PTO-1449. The statement is not a representation that all of the information cited is necessarily effective as prior art against the application.

Respectfully submitted,

Date: September 30, 2004

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FORM PTO-1449 (MODIFIED)	ATTY. DOCKET NO. 905900-290	SERIAL NO. 10/715,870
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT (USE SEVERAL SHEETS IF NECESSARY)	APPLICANT: George BORSHUKOV	
	FILING DATE: November 17, 2003	GROUP: 2125

Reference Designation

U.S. Patents

Examiner Initial	Document Number	Date	Name	Class	Filing Date Subclass if appropriate
	AA 6,044,180	03/28/00	Brandestini et al.		
	AB 6,148,113	11/14/00	Wolverton et al.		
	AC 6,166,744	12/26/00	Jaszlics et al.		
	AD 6,124,864	09/26/00	Madden et al.		
	AE 6,160,907	12/12/00	Robotham et al.		
	AF 6,538,396	03/25/03	Vlahos et al.		
	AG 6,628,298	09/30/03	Debevec		
	AH 6,519,360	02/11/03	Tanaka		
	AI 6,628,830	09/30/03	Yamazoe et al.		
	AJ 6,552,731	04/22/03	Gonsalves		
	AK 6,564,108	03/15/03	Markar et al.		
	AL 6,657,637	12/02/03	Inagaki et al.		
	AM 2003/0202120	10/30/03	Mack		
	AN 2003/0103057	06/05/03	Graves et al.		
	AO 2002/0186314	12/12/02	Debevec		
	AP 2003/0012448	01/16/03	Kimmel et al.		
	AQ 6,571,024	05/27/03	Sawhney et al.		
	AR 5,499,306	03/12/96	Sasaki et al.		
	AS 6,362,822	03/26/02	Randel		
	AT 5,974,168	10/26/99	Rushmeier et al.		

FOREIGN PATENT DOCUMENTS

Document Number	Date	Country	Class	Filing Date Subclass if appropriate
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OTHER ART (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

AV "Spectral Reflectance, BRDF, Hyperspectral Imaging, Thermal Coatings, FTirs etc.	Surface Optics Corporation; pages 1-7; www.surfaceoptics.com ;
AW "A Survey of BRDF Representation for Computer Graphics" by Szymon Rusinkiewicz	CS348, Winter 1997; pages 1-14); www.cs.princeton.edu/smr/cs348c-97/surveypaper.html
AX "An Architecture for Accelerated Anisotropic Shading" by Stephen Ehmann	Thesis Submitted for B.S. Degree at University of Toronto; Supervisor, M. Van De Panne, April 1998 Division of Engineering Science
AY "A Data-Driven Reflectance Model" by Wojciech Matusik et al.	
AZ "Acquiring Parameters for Rendering" by Zack Waters	Realistic Raytracing; pages 1 - 11; www.cs.wpi.edu/emmanuel/courses/cs563/write_ups/zackw_measurement

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.